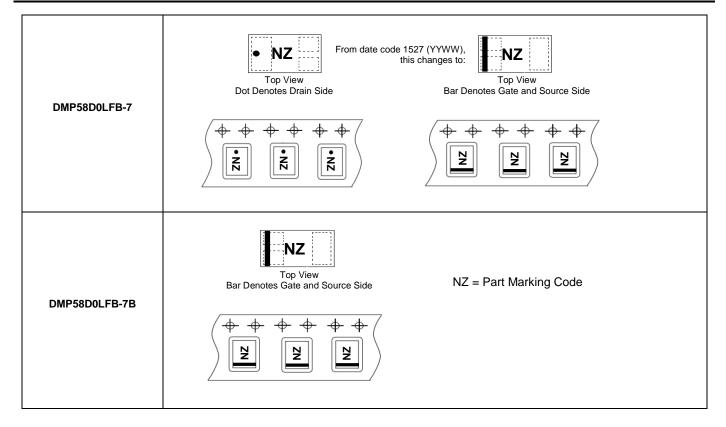


# Marking Information



# Maximum Ratings (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Character	Symbol	Value	Unit		
Drain-Source Voltage			V <sub>DSS</sub>	-50	V
Gate-Source Voltage			V <sub>GSS</sub>	±20	V
Continuous Drain Current (Note 5) $V_{GS}$ = -5V	Steady State	$T_{A} = +25^{\circ}C$ $T_{A} = +70^{\circ}C$	ID	-180 -150	mA
Continuous Drain Current (Note 6) $V_{GS} = -5V$	Steady State	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	ID	-310 -250	mA
Pulsed Drain Current (Note 7)			I <sub>DM</sub>	-500	mA

## **Thermal Characteristics**

Characteristic	Symbol	Max	Unit
Power Dissipation (Note 5)	PD	0.47	W
Thermal Resistance, Junction to Ambient $@T_A = +25^{\circ}C$ (Note 5)	R <sub>0JA</sub>	258	°C/W
Power Dissipation (Note 6)	PD	1.22	W
Thermal Resistance, Junction to Ambient $@T_A = +25^{\circ}C$ (Note 6)	R <sub>0JA</sub>	105	°C/W
Operating and Storage Temperature Range	TJ, T <sub>STG</sub>	-55 to +150	C°



Notes:

# Electrical Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Мах	Unit	Test Condition	
OFF CHARACTERISTICS (Note 8)							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	-50	_	_	V	$V_{GS} = 0V, I_D = -250\mu A$	
Zero Gate Voltage Drain Current TJ = +25°C	I <sub>DSS</sub>	_	_	-1.0	μA	$V_{DS} = -50V, V_{GS} = 0V$	
Gate-Source Leakage	I <sub>GSS</sub>	_	_	±5	μA	$V_{GS} = \pm 20V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 8)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	-0.8	—	-2.1	V	$V_{DS} = V_{GS}$ , $I_D = -250 \mu A$	
Static Drain-Source On-Resistance		_	6	8	Ω	$V_{GS} = -5V, I_D = -100mA$	
Static Drain-Source On-Resistance	R <sub>DS(ON)</sub>	_	12	18	Ω	V <sub>GS</sub> = -2.5V, I <sub>D</sub> = -10mA	
Forward Transfer Admittance	Y <sub>fs</sub>	0.05		_	S	$V_{DS} = -25V, I_D = -100mA$	
DYNAMIC CHARACTERISTICS (Note 9)						•	
Input Capacitance	Ciss	_	27	_		$V_{DS}$ = -25V, $V_{GS}$ = 0V, f = 1.0MHz	
Output Capacitance	Coss		4.0	_	pF		
Reverse Transfer Capacitance	C <sub>rss</sub>	_	1.4	—			
Turn-On Delay Time	t <sub>D(ON)</sub>	_	30.7	_		$V_{GS} = -4.5V, V_{DS} = -30V,$ $R_G = 50\Omega, I_D = -10mA$	
Turn-On Rise Time	t <sub>R</sub>	_	84.1	_			
Turn-Off Delay Time	t <sub>D(OFF)</sub>	_	201.8		ns		
Turn-Off Fall Time	t <sub>F</sub>	—	32.2	—			

5. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.

6. Device mounted on FR-4 substrate PC board, 2oz copper, with thermal vias to bottom layer 1inch square copper plate.

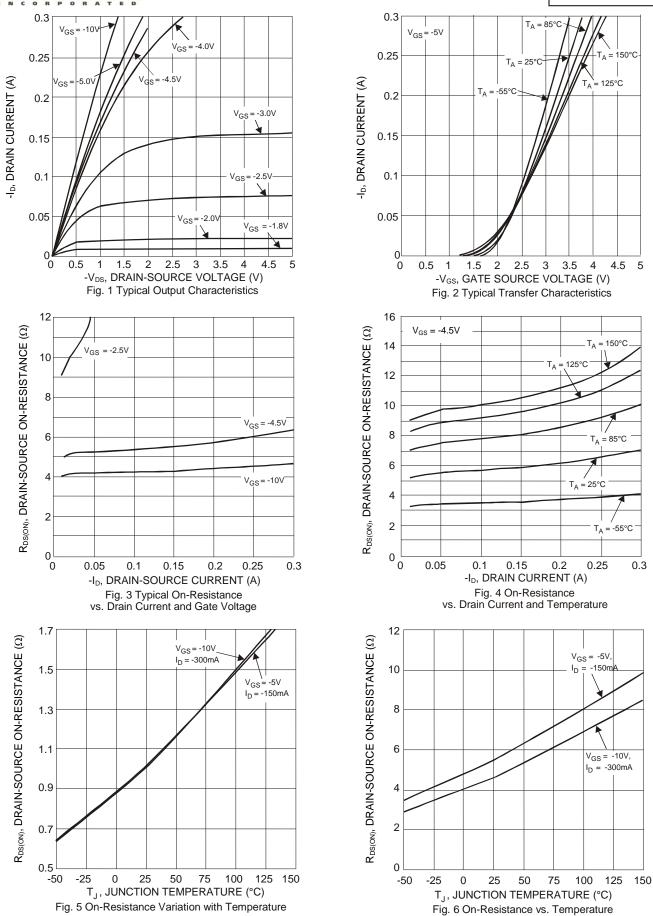
7. Repetitive rating, pulse width limited by junction temperature.

8. Short duration pulse test used to minimize self-heating effect.

9. Guaranteed by design. Not subject to production testing.



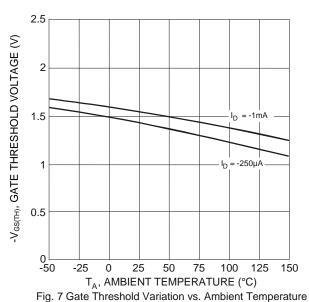


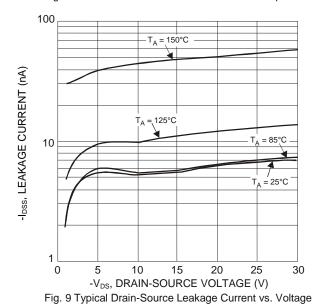


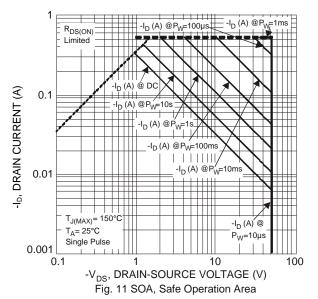
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# DMP58D0LFB







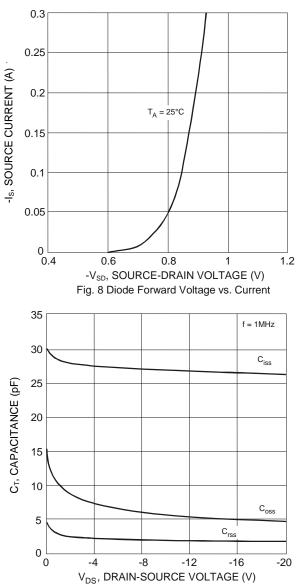
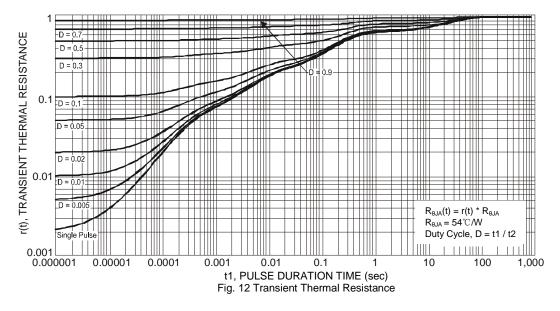


Fig. 10 Typical Junction Capacitance

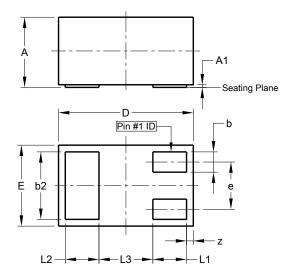




## **Package Outline Dimensions**

Please see http://www.diodes.com/package-outlines.html for the latest version.

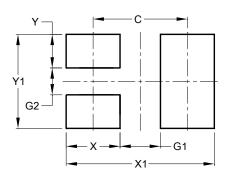
## X1-DFN1006-3



X1-DFN1006-3						
Dim	Min	Max	Тур			
Α	0.47	0.53	0.50			
A1	0.00	0.05	0.03			
b	0.10	0.20	0.15			
b2	0.45	0.55	0.50			
D	0.95	1.075	1.00			
Е	0.55	0.675	0.60			
е	-	-	0.35			
L1	0.20	0.30	0.25			
L2	0.20	0.30	0.25			
L3	-	-	0.40			
Z	0.02	0.08	0.05			
All Dimensions in mm						

## Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.



## X1-DFN1006-3

Dimensions	Value (in mm)
С	0.70
G1	0.30
G2	0.20
Х	0.40
X1	1.10
Y	0.25
Y1	0.70



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